

Certificate of Analysis IARM 18D

Nitronic 60 / UNS S21800

Certified Reference Material

Certified Values listed in wt.% with associated uncertainties

ΑI	0.006 ± 0.002	В	0.0011 ± 0.0006	C	0.069 ± 0.003	Co	0.086 ± 0.005
Cr	16.7 ± 0.1	Cu	0.421 ± 0.005	Mn	8.1 ± 0.1	Mo	0.325 ± 0.007
N	0.170 ± 0.008	Nb	0.031 ± 0.007	Ni	8.39 ± 0.08	Р	0.032 ± 0.002
S	0.0025 ± 0.0006	Si	3.68 ± 0.06	Sn	0.007 ± 0.002	Ti	0.012 ± 0.001
V	0.064 + 0.002	W	0 026 + 0 004				

Indicative Values listed in ppm

As (70)	Bi (<10)	Ca (20)	Cd (<10)	Ce (<50)	Mg (<210)	O (40)
Pb (<1100)	Sb (<40)	Se (<300)	Ta (100)	Zn (<200)	Zr (50)	

Description and Intended Use

This CRM may come in the form of a solid disc or chips. The intended use of this CRM may include, but is not limited to, the calibration of instruments and the validation of analytical methods.

Interpretation of Data

- 1. Certified values listed reflect analysis results submitted by qualified analytical laboratories using a combination of methods and instrumentation that emulate actual methods and instrumental techniques currently utilized in the analytical community, and are reported as wt% unless otherwise noted.
- 2. This material was tested using both the solid disks and chips prepared from individual sections of bar. The certified values are considered representative of the overall average composition of the material.
- 3. Any data reported and enclosed by a parentheses () is a "best estimate" and is not certified. This data could not be quantified sufficiently for certification. It was, however, reported by enough laboratories to be considered as potentially present in the matrix of the material being examined.
- 4. "Provisional Certificate of Analysis" reports values that support a fully certified reference material; it also indicates that values may be in a continued process of statistical evaluation and are subject to change.
- 5. Chips are not certified for Oxygen analysis.



The following data and accompanying statements represent all pertinent information reported in the ILAP as it applies to the chemical characterization of this material.

	Al	As	В	Bi	С	Ca	Cd	Се	Со	Cr	Cu	Mg	Mn	Мо	N	Nb
1 1	0.0022	0.005	0.0001	<0.0010	0.06	0.0023	<0.0010	<0.005	0.0706	16.433	0.4098	0.0002	7.839	0.313	0.152	0.023
2	0.0023	0.008	0.00067		0.0647	0.0026			0.08	16.512	0.41	0.0015	7.92	0.313	0.163	0.024
3	0.005	0.008	0.001		0.0647				0.081	16.561	0.4125	0.021	7.9539	0.314	0.166	0.0243
4	0.0054		0.0011		0.0662				0.0831	16.57	0.416		7.974	0.316	0.17	0.025
5	0.0056		0.0011		0.068				0.084	16.60	0.421		7.977	0.3178	0.1704	0.026
6	0.0058		0.0014		0.0721				0.084	16.616	0.422		7.99	0.32	0.1772	0.026
7	0.0061		0.0023		0.0726				0.085	16.64	0.4227		7.9952	0.3244	0.1789	0.029
8	0.0072				0.0731				0.0865	16.6453	0.423		8.035	0.327	0.1822	0.03
9	0.0079				0.07383				0.089	16.70	0.4245		8.0385	0.33	01.0	0.0304
10	0.008				0.074				0.0912	16.8297	0.428		8.07	0.331		0.051
11	0.011				0.07459				0.0925	16.87	0.43		8.0982	0.332		0.052
12	0.011				0.07 400				0.102	16.9784	0.4343		8.377	0.3424		0.002
13									0.102	10.5704	0.4040		8.3875	0.346		
14													0.3073	0.540		
15																
Mean	0.006	0.007	0.0011		0.069	0.002			0.086	16.7	0.421	0.01	8.1	0.325	0.17	0.031
STDV.	0.008	0.007	0.0011			0.002			0.008	0.2	0.421	0.01	0.2	0.323	0.17	0.031
				(40.001)	0.005		(-0.001)	(=0 00E)							0.01 0.170	
Certified	0.006	(0.007)	0.0011	(<0.001)	0.069	(0.002)	(<0.001)	(<0.005)	0.086	16.7	0.421	(<0.021)	8.1	0.325		0.031
95% C.I. Methods	0.002 X,O,I,G	O,I	0.0006 O,I,G		0.003 O,C	O,I			0.005	0.1	0.005	l 0.	0.1	0.007 X,O,I,G	0.008 F	0.007
I MEIDUUS I	1 X () 1 (-	()														
Modifieds	7,0,1,0	<u></u>	0,1,0	l I	0,0	O,i	ı	O,I	X,O,I	X,W,O,I,G	X,O,I,G	O,I	X,O,I,G	7,0,1,0	ı	X,O,I,G
Wictious		0	P	Pb		·	Se					V	-		<u> </u>	X,O,I,O
1	Ni	0	Р	Pb 0.001	S	Sb	Se 0.007	Si	Sn	Та	Ti	V	W	Zn	Zr	, X,O,I,O
1	Ni 8.145	O 0.002	P 0.027	0.001	S 0.0011	Sb <0.0010	0.007	Si 3.551	Sn 0.004	Ta	Ti 0.0088	V	W 0.02	Zn 0.02	Zr 0.0012	7,0,1,0
1 2	Ni 8.145 8.28	O 0.002 0.0035	P 0.027 0.027	0.001 0.0017	S 0.0011 0.0018	Sb	0.007 0.026	Si 3.551 3.596	Sn 0.004 0.0046	Ta 0.0034 0.0038	Ti 0.0088 0.0104	V 0.06 0.0605	W 0.02 0.022	Zn	Zr 0.0012 0.004	7,0,1,0
1	Ni 8.145 8.28 8.294	0.002 0.0035 0.0041	P 0.027 0.027 0.0284	0.001 0.0017 0.04	\$ 0.0011 0.0018 0.002	Sb <0.0010	0.007	Si 3.551 3.596 3.624	Sn 0.004 0.0046 0.005	Ta 0.0034 0.0038 0.0039	Ti 0.0088 0.0104 0.0106	V 0.06 0.0605 0.061	W 0.02 0.022 0.022	Zn 0.02	Zr 0.0012 0.004 0.008	7,0,1,0
1 2 3 4	Ni 8.145 8.28 8.294 8.338	O 0.002 0.0035	P 0.027 0.027 0.0284 0.0298	0.001 0.0017 0.04 0.106	\$ 0.0011 0.0018 0.002 0.0021	Sb <0.0010	0.007 0.026	Si 3.551 3.596 3.624 3.6252	\$n 0.004 0.0046 0.005 0.006	Ta 0.0034 0.0038 0.0039 0.004	Ti 0.0088 0.0104 0.0106 0.011	V 0.06 0.0605 0.061 0.062	0.02 0.022 0.022 0.0236	Zn 0.02	Zr 0.0012 0.004 0.008 0.0086	7,0,1,0
1 2 3 4 5	Ni 8.145 8.28 8.294 8.338 8.346	0.002 0.0035 0.0041	P 0.027 0.027 0.0284 0.0298 0.03	0.001 0.0017 0.04	\$ 0.0011 0.0018 0.002 0.0021 0.00221	Sb <0.0010	0.007 0.026	\$i 3.551 3.596 3.624 3.6252 3.626	\$n 0.004 0.0046 0.005 0.006 0.006	Ta 0.0034 0.0038 0.0039 0.004 0.031	Ti 0.0088 0.0104 0.0106 0.011 0.0118	V 0.06 0.0605 0.061 0.062 0.062	W 0.02 0.022 0.022 0.0236 0.024	Zn 0.02	Zr 0.0012 0.004 0.008	7,0,1,0
1 2 3 4	Ni 8.145 8.28 8.294 8.338 8.346 8.3558	0.002 0.0035 0.0041	P 0.027 0.027 0.0284 0.0298 0.03 0.03	0.001 0.0017 0.04 0.106	\$ 0.0011 0.0018 0.002 0.0021 0.00221 0.0026	Sb <0.0010	0.007 0.026	\$i 3.551 3.596 3.624 3.6252 3.626 3.64	\$n 0.004 0.0046 0.005 0.006 0.006 0.0072	Ta 0.0034 0.0038 0.0039 0.004	Ti 0.0088 0.0104 0.0106 0.011 0.0118 0.012	V 0.06 0.0605 0.061 0.062 0.062 0.062	0.02 0.022 0.022 0.022 0.0236 0.024 0.028	Zn 0.02	Zr 0.0012 0.004 0.008 0.0086	7,0,1,0
1 2 3 4 5 6 7	Ni 8.145 8.28 8.294 8.338 8.346 8.3558 8.379	0.002 0.0035 0.0041	P 0.027 0.027 0.0284 0.0298 0.03 0.03 0.03	0.001 0.0017 0.04 0.106	\$ 0.0011 0.0018 0.002 0.0021 0.00221 0.0026 0.0026	Sb <0.0010	0.007 0.026	\$i 3.551 3.596 3.624 3.6252 3.626 3.64 3.693	\$n 0.004 0.0046 0.005 0.006 0.006 0.0072 0.0093	Ta 0.0034 0.0038 0.0039 0.004 0.031	Ti 0.0088 0.0104 0.0106 0.011 0.0118 0.012 0.012	V 0.06 0.0605 0.061 0.062 0.062 0.062 0.0625	0.02 0.022 0.022 0.0236 0.024 0.028 0.028	Zn 0.02	Zr 0.0012 0.004 0.008 0.0086	7,0,1,0
1 2 3 4 5 6 7 8	Ni 8.145 8.28 8.294 8.338 8.346 8.3558 8.379 8.40	0.002 0.0035 0.0041	P 0.027 0.027 0.0284 0.0298 0.03 0.03 0.03	0.001 0.0017 0.04 0.106	\$ 0.0011 0.0018 0.002 0.0021 0.00221 0.0026 0.0026 0.0027	Sb <0.0010	0.007 0.026	\$i 3.551 3.596 3.624 3.6252 3.626 3.64 3.693 3.7032	\$n 0.004 0.0046 0.005 0.006 0.006 0.0072	Ta 0.0034 0.0038 0.0039 0.004 0.031	Ti 0.0088 0.0104 0.0106 0.011 0.0118 0.012 0.012 0.013	V 0.06 0.0605 0.061 0.062 0.062 0.062 0.0625 0.063	0.02 0.022 0.022 0.0236 0.024 0.028 0.028	Zn 0.02	Zr 0.0012 0.004 0.008 0.0086	7,0,1,0
1 2 3 4 5 6 7 8	Ni 8.145 8.28 8.294 8.338 8.346 8.3558 8.379 8.40 8.4294	0.002 0.0035 0.0041	P 0.027 0.027 0.0284 0.0298 0.03 0.03 0.03 0.032 0.032	0.001 0.0017 0.04 0.106	\$ 0.0011 0.0018 0.002 0.0021 0.00221 0.0026 0.0026 0.0027 0.00281	Sb <0.0010	0.007 0.026	\$i 3.551 3.596 3.624 3.6252 3.626 3.64 3.693 3.7032 3.71	\$n 0.004 0.0046 0.005 0.006 0.006 0.0072 0.0093	Ta 0.0034 0.0038 0.0039 0.004 0.031	Ti 0.0088 0.0104 0.0106 0.011 0.0118 0.012 0.012	V 0.06 0.0605 0.061 0.062 0.062 0.062 0.062 0.063	0.02 0.022 0.022 0.0236 0.024 0.028 0.028 0.028 0.0285 0.033	Zn 0.02	Zr 0.0012 0.004 0.008 0.0086	7,0,1,0
1 2 3 4 5 6 7 8 9	Ni 8.145 8.28 8.294 8.338 8.346 8.3558 8.379 8.40 8.4294 8.4394	0.002 0.0035 0.0041	P 0.027 0.027 0.0284 0.0298 0.03 0.03 0.03 0.032 0.032	0.001 0.0017 0.04 0.106	\$ 0.0011 0.0018 0.002 0.0021 0.00221 0.0026 0.0026 0.0027 0.00281 0.003	Sb <0.0010	0.007 0.026	\$i 3.551 3.596 3.624 3.6252 3.626 3.64 3.693 3.7032 3.71 3.7622	\$n 0.004 0.0046 0.005 0.006 0.006 0.0072 0.0093	Ta 0.0034 0.0038 0.0039 0.004 0.031	Ti 0.0088 0.0104 0.0106 0.011 0.0118 0.012 0.012 0.013	V 0.06 0.0605 0.061 0.062 0.062 0.062 0.0625 0.063 0.063 0.0654	0.02 0.022 0.022 0.0236 0.024 0.028 0.028	Zn 0.02	Zr 0.0012 0.004 0.008 0.0086	7,0,1,0
1 2 3 4 5 6 7 8 9 10 11	Ni 8.145 8.28 8.294 8.338 8.346 8.3558 8.379 8.40 8.4294 8.4394 8.4394	0.002 0.0035 0.0041	P 0.027 0.027 0.0284 0.0298 0.03 0.03 0.03 0.032 0.032 0.032 0.0326 0.0359	0.001 0.0017 0.04 0.106	\$ 0.0011 0.0018 0.002 0.0021 0.00221 0.0026 0.0026 0.0027 0.00281	Sb <0.0010	0.007 0.026	\$i 3.551 3.596 3.624 3.6252 3.626 3.64 3.693 3.7032 3.71 3.7622 3.777	\$n 0.004 0.0046 0.005 0.006 0.006 0.0072 0.0093	Ta 0.0034 0.0038 0.0039 0.004 0.031	Ti 0.0088 0.0104 0.0106 0.011 0.0118 0.012 0.012 0.013	V 0.06 0.0605 0.061 0.062 0.062 0.062 0.063 0.063 0.063 0.0654	0.02 0.022 0.022 0.0236 0.024 0.028 0.028 0.028 0.0285 0.033	Zn 0.02	Zr 0.0012 0.004 0.008 0.0086	7,0,1,0
1 2 3 4 5 6 7 8 9 10 11 12	Ni 8.145 8.28 8.294 8.338 8.346 8.3558 8.379 8.40 8.4294 8.4394 8.4394 8.46 8.499	0.002 0.0035 0.0041	P 0.027 0.027 0.0284 0.0298 0.03 0.03 0.032 0.032 0.032 0.0326 0.0359 0.036	0.001 0.0017 0.04 0.106	\$ 0.0011 0.0018 0.002 0.0021 0.00221 0.0026 0.0026 0.0027 0.00281 0.003	Sb <0.0010	0.007 0.026	\$i 3.551 3.596 3.624 3.6252 3.626 3.64 3.693 3.7032 3.71 3.7622	\$n 0.004 0.0046 0.005 0.006 0.006 0.0072 0.0093	Ta 0.0034 0.0038 0.0039 0.004 0.031	Ti 0.0088 0.0104 0.0106 0.011 0.0118 0.012 0.012 0.013	V 0.06 0.0605 0.061 0.062 0.062 0.062 0.063 0.063 0.063 0.0654 0.0654	0.02 0.022 0.022 0.0236 0.024 0.028 0.028 0.028 0.0285 0.033	Zn 0.02	Zr 0.0012 0.004 0.008 0.0086	7,0,1,0
1 2 3 4 5 6 7 8 9 10 11 12 13	Ni 8.145 8.28 8.294 8.338 8.346 8.3558 8.379 8.40 8.4294 8.4394 8.4394	0.002 0.0035 0.0041	P 0.027 0.027 0.0284 0.0298 0.03 0.03 0.03 0.032 0.032 0.032 0.0326 0.0359	0.001 0.0017 0.04 0.106	\$ 0.0011 0.0018 0.002 0.0021 0.00221 0.0026 0.0026 0.0027 0.00281 0.003	Sb <0.0010	0.007 0.026	\$i 3.551 3.596 3.624 3.6252 3.626 3.64 3.693 3.7032 3.71 3.7622 3.777	\$n 0.004 0.0046 0.005 0.006 0.006 0.0072 0.0093	Ta 0.0034 0.0038 0.0039 0.004 0.031	Ti 0.0088 0.0104 0.0106 0.011 0.0118 0.012 0.012 0.013	V 0.06 0.0605 0.061 0.062 0.062 0.062 0.063 0.063 0.063 0.0654	0.02 0.022 0.022 0.0236 0.024 0.028 0.028 0.028 0.0285 0.033	Zn 0.02	Zr 0.0012 0.004 0.008 0.0086	7,0,1,0
1 2 3 4 5 6 7 8 9 10 11 12 13 14	Ni 8.145 8.28 8.294 8.338 8.346 8.3558 8.379 8.40 8.4294 8.4394 8.4394 8.46 8.499	0.002 0.0035 0.0041	P 0.027 0.027 0.0284 0.0298 0.03 0.03 0.032 0.032 0.032 0.0326 0.0359 0.036	0.001 0.0017 0.04 0.106	\$ 0.0011 0.0018 0.002 0.0021 0.00221 0.0026 0.0026 0.0027 0.00281 0.003	Sb <0.0010	0.007 0.026	\$i 3.551 3.596 3.624 3.6252 3.626 3.64 3.693 3.7032 3.71 3.7622 3.777	\$n 0.004 0.0046 0.005 0.006 0.006 0.0072 0.0093	Ta 0.0034 0.0038 0.0039 0.004 0.031	Ti 0.0088 0.0104 0.0106 0.011 0.0118 0.012 0.012 0.013	V 0.06 0.0605 0.061 0.062 0.062 0.062 0.063 0.063 0.063 0.0654 0.0654	0.02 0.022 0.022 0.0236 0.024 0.028 0.028 0.028 0.0285 0.033	Zn 0.02	Zr 0.0012 0.004 0.008 0.0086	7,0,1,0
1 2 3 4 5 6 7 8 9 10 11 12 13 14 15	Ni 8.145 8.28 8.294 8.338 8.346 8.3558 8.379 8.40 8.4294 8.4394 8.46 8.499 8.7025	0.002 0.0035 0.0041 0.0052	P 0.027 0.027 0.0284 0.0298 0.03 0.03 0.032 0.032 0.032 0.0326 0.0359 0.036 0.039	0.001 0.0017 0.04 0.106 <0.0010	\$ 0.0011 0.0018 0.002 0.0021 0.00221 0.0026 0.0026 0.0027 0.00281 0.003 0.0048	Sb <0.0010	0.007 0.026	\$i 3.551 3.596 3.624 3.6252 3.626 3.64 3.693 3.7032 3.71 3.7622 3.777 3.8902	\$n 0.004 0.0046 0.005 0.006 0.0072 0.0093 0.0115	Ta 0.0034 0.0038 0.0039 0.004 0.031 <0.0010	Ti 0.0088 0.0104 0.0106 0.011 0.0118 0.012 0.012 0.013 0.0139	V 0.06 0.0605 0.061 0.062 0.062 0.062 0.063 0.063 0.063 0.0654 0.0654 0.071 0.0719	W 0.02 0.022 0.022 0.0236 0.024 0.028 0.028 0.0285 0.033 0.0349	Zn 0.02	Zr 0.0012 0.004 0.008 0.0086 <0.0010	7,0,1,0
1 2 3 4 5 6 7 8 9 10 11 12 13 14 15 Mean	Ni 8.145 8.28 8.294 8.338 8.346 8.3558 8.379 8.40 8.4294 8.4394 8.499 8.7025	0.002 0.0035 0.0041 0.0052	P 0.027 0.027 0.0284 0.0298 0.03 0.03 0.032 0.032 0.0326 0.0359 0.036 0.039	0.001 0.0017 0.04 0.106 <0.0010	\$ 0.0011 0.0018 0.002 0.0021 0.00221 0.0026 0.0026 0.0027 0.00281 0.003 0.0048	Sb <0.0010	0.007 0.026	\$i 3.551 3.596 3.624 3.6252 3.626 3.64 3.693 3.7032 3.71 3.7622 3.777 3.8902	\$n 0.004 0.0046 0.005 0.006 0.0072 0.0093 0.0115	Ta 0.0034 0.0038 0.0039 0.004 0.031 <0.0010	Ti 0.0088 0.0104 0.0106 0.011 0.0118 0.012 0.012 0.013 0.0139	V 0.06 0.0605 0.061 0.062 0.062 0.062 0.063 0.063 0.063 0.0654 0.071 0.0719	0.02 0.022 0.022 0.0236 0.024 0.028 0.028 0.028 0.033 0.0349	Zn 0.02	Zr 0.0012 0.004 0.008 0.0086 <0.0010	7,0,1,0
1 2 3 4 5 6 7 8 9 10 11 12 13 14 15 Mean STDV.	Ni 8.145 8.28 8.294 8.338 8.346 8.3558 8.379 8.40 8.4294 8.4394 8.499 8.7025	0.002 0.0035 0.0041 0.0052 0.004 0.004	P 0.027 0.027 0.0284 0.0298 0.03 0.03 0.032 0.032 0.0326 0.0359 0.036 0.039	0.001 0.0017 0.04 0.106 <0.0010	\$ 0.0011 0.0018 0.002 0.0021 0.00221 0.0026 0.0026 0.0027 0.00281 0.003 0.0048 0.0025 0.0009	Sb <0.0010 <0.004	0.007 0.026 <0.0010	\$i 3.551 3.596 3.624 3.6252 3.626 3.64 3.693 3.7032 3.71 3.7622 3.777 3.8902	\$n 0.004 0.0046 0.005 0.006 0.0072 0.0093 0.0115	Ta 0.0034 0.0038 0.0039 0.004 0.031 <0.0010	Ti 0.0088 0.0104 0.0106 0.011 0.0118 0.012 0.012 0.013 0.0139	V 0.06 0.0605 0.061 0.062 0.062 0.062 0.063 0.063 0.0654 0.0654 0.071 0.0719	0.02 0.022 0.022 0.0236 0.024 0.028 0.028 0.028 0.033 0.0349	Zn 0.02 <0.0010	Zr 0.0012 0.004 0.008 0.0086 <0.0010 0.005 0.003	7,0,1,0
1 2 3 4 5 6 7 8 9 10 11 12 13 14 15 Mean STDV.	Ni 8.145 8.28 8.294 8.338 8.346 8.3558 8.379 8.40 8.4294 8.4394 8.46 8.499 8.7025	0.002 0.0035 0.0041 0.0052	P 0.027 0.027 0.0284 0.0298 0.03 0.03 0.032 0.032 0.0326 0.0359 0.036 0.039 0.032 0.032	0.001 0.0017 0.04 0.106 <0.0010	\$ 0.0011 0.0018 0.002 0.0021 0.00221 0.0026 0.0026 0.0027 0.00281 0.003 0.0048 0.0025 0.0009 0.0025	Sb <0.0010	0.007 0.026	\$i 3.551 3.596 3.624 3.6252 3.626 3.64 3.693 3.7032 3.71 3.7622 3.777 3.8902 3.68 0.09 3.68	\$n 0.004 0.0046 0.005 0.006 0.0072 0.0093 0.0115 0.007 0.003 0.007	Ta 0.0034 0.0038 0.0039 0.004 0.031 <0.0010	Ti 0.0088 0.0104 0.0106 0.011 0.0118 0.012 0.012 0.013 0.0139 0.012 0.012 0.012	V 0.06 0.0605 0.061 0.062 0.062 0.062 0.063 0.063 0.0654 0.0654 0.071 0.0719	0.02 0.022 0.022 0.0236 0.024 0.028 0.028 0.0285 0.033 0.0349 0.036 0.005	Zn 0.02	Zr 0.0012 0.004 0.008 0.0086 <0.0010	7,0,1,0
1 2 3 4 5 6 7 8 9 10 11 12 13 14 15 Mean STDV.	Ni 8.145 8.28 8.294 8.338 8.346 8.3558 8.379 8.40 8.4294 8.4394 8.499 8.7025	0.002 0.0035 0.0041 0.0052 0.004 0.004	P 0.027 0.027 0.0284 0.0298 0.03 0.03 0.032 0.032 0.0326 0.0359 0.036 0.039	0.001 0.0017 0.04 0.106 <0.0010	\$ 0.0011 0.0018 0.002 0.0021 0.00221 0.0026 0.0026 0.0027 0.00281 0.003 0.0048 0.0025 0.0009	Sb <0.0010 <0.004	0.007 0.026 <0.0010	\$i 3.551 3.596 3.624 3.6252 3.626 3.64 3.693 3.7032 3.71 3.7622 3.777 3.8902	\$n 0.004 0.0046 0.005 0.006 0.0072 0.0093 0.0115 0.007 0.003 0.007 0.002	Ta 0.0034 0.0038 0.0039 0.004 0.031 <0.0010	Ti 0.0088 0.0104 0.0106 0.011 0.0118 0.012 0.012 0.013 0.0139	V 0.06 0.0605 0.061 0.062 0.062 0.062 0.063 0.063 0.0654 0.0654 0.071 0.0719	0.02 0.022 0.022 0.0236 0.024 0.028 0.028 0.028 0.033 0.0349	Zn 0.02 <0.0010	Zr 0.0012 0.004 0.008 0.0086 <0.0010 0.005 0.003	7,0,1,0

Legend: W = Classical, C = Combustion, F = Fusion, A = AA or GFAA, I = ICP or DCP, IM=ICP-MS, D = DC Arc, O = AES, X = XRF, G = GDAES or GDMS, H = Hollow Cathode AES



Participating Laboratories

Anderson Laboratories, Inc.
Chicago Spectro Service Laboratory
Davis Alloys Manufacturing, LLC
Laboratory Testing, Inc.
LECO Corporation

Greendale, WI Chicago, IL Sharpsville, PA Hatfield, PA St. Joseph, MI

Cronimet Specialty Metals USA, Inc. Kennametal Stellite, Inc. Latrobe Specialty Metals, A Carpenter Co. VHG Labs

Carpenter Technology - Athens Operations

Tanner, AL Wheatland, PA Belleville, ON Latrobe, PA Manchester, NH

Traceability

Members of the "Inter-Laboratory Analysis Program" (ILAP) validate test methods and instrument performance utilizing SRMs, CRMs, and RMs produced by recognized Certifying Bodies. The specific SRMs, CRMs, and RMs applicable to the material covered by this certificate are:

ALPHA AR1652	ALPHA AR882	C1287	IARM 18A	IARM 26B	LECO 501-502	LECO 502-072	NIST 1155A	NIST 3101A
ALPHA AR654	APLHA AR882	IARM 152A	IARM 18B	IARM 2C	LECO 501-503	LECO 502-414	NIST 121D	NIST 3132
ALPHA AR663	BS 181A	IARM 17A	IARM 18C	IARM 4C	LECO 502-016	LECO 502-887	NIST 1763	NIST 339
ALPHA AR869	BS 191							

Homogeneity and Uncertainty

"Uncertainty" values, as reported adjacent to certified concentration values, are based on a 95% Confidence Interval. These estimated uncertainties include the combined effects of method imprecision, material inhomogeneity, and any bias between methods. Homogeneity data from experimental XRF results are reflected in both the overall statistics and certified data. Homogeneity samples are selected by a systematic sampling procedure. The number of samples may be determined by equation 1, where N_{prod} is the number of units produced and N_{min} is the number of samples used for homogeneity testing. These samples are arranged in a simple randomized design such that each sample is analyzed multiple times by XRF. Homogeneity is also determined within sample using an applied version of ASTM E826. A single factor ANOVA is used to calculated uncertainty due to inhomogeneity (U_{hom}). Uncertainty of the material is calculated by equation 2, where H=U_{hom}, S= Standard deviation, t= t-value at 95% CI, and n= number of observations.

1.
$$N_{min} = \max(10, \sqrt[3]{N_{prod}})$$
2. $U_{CRM} = \frac{\sqrt{H^2 + S^2}}{\sqrt{n}} * t$

The International Standards Organization (ISO) definitions, expressed in ISO Guide 30–1992 list the following:

<u>Certifying Body:</u> Any technically competent body (organization or firm, public or private) that issues a reference material certificate with the information detailed in ISO Guide 31. The only generally accepted certifying body in the United States for primary standards or Standard Reference Materials (SRM) is the U. S. Department of Commerce, National Institute of Standards & Technology (NIST), Gaithersburg, MD. All other certifying bodies in the United States produce Reference Materials (RM) or Certified Reference Materials (CRM).

Reference Material (RM): Material or substance, with one or more property values that are sufficiently homogeneous and well established, to be used for the calibration of an apparatus, the assessment of a measurement method, or for assigning values to materials.

<u>Certified Reference Material (CRM):</u> Reference material, accompanied by a certificate, with one or more property values certified by a procedure, which establishes its traceability to an accurate realization of the unit in which the property values are expressed, and for which each certified value is accompanied by an uncertainty at a stated level of confidence.

<u>Inter-Laboratory Analysis Program (ILAP):</u> ASTM Standard E691-87 applies to inter-laboratory studies to "Determine the Precision of a Single Test Method", but also outlines a well thought out and logical plan for conducting an inter laboratory program involving multiple analytical techniques. Therefore, the guidelines established in ASTM E691-87 were applied to all aspects of this inter laboratory program, including the protocols for planning, handling, analysis and treatment of resulting data.

Methods of Analysis: The "Inter Laboratory Analysis Program" analyzes a wide variety of materials, and as a result, no single analytical method would provide optimum analytical results. Therefore, a combination of ASTM Standard Methods for classical wet chemistry, ICP, AA, Optical Emission, X-Ray spectrometric, and other accepted methods were used to produce analytical data. Carbon, Sulfur, Nitrogen, and Oxygen results were supplied from combustion and OE instrument procedures.

Expiration of Certification: The certification of this IARM is valid indefinitely, within the uncertainty specified, provided the IARM is handled and stored in accordance with the instructions stated on this certificate. The certification is nullified if the IARM is damaged, contaminated, otherwise modified, or used in a manner for which it was not intended.

Instructions for Use: The test surface is on the side opposite to the labeled surface, which includes the IARM number. The entire thickness of the unit is certified. However, the user is cautioned not to measure disks less than 2 mm thick when using X-ray fluorescence spectrometry. Each packaged disk has been prepared by finishing the test surface using a lathe. The user must determine the correct surface preparation procedure for each analytical technique. The user is cautioned to use care when either resurfacing the disk or performing additional polishing, as these processes may contaminate the surface. The minimum sample size for chips should be individually evaluated based on the analytical technique used; this would typically be greater than 0.1 grams. The material should be stored in a cool, dry location when not in use. Chips are not to be used for Oxygen analysis.

<u>Selection of Materials:</u> A "batch" or "series" is defined as a continuous length of bar produced from a single heat. The majority of IARM materials are in wrought condition; other methods of manufacture are utilized if necessary. ILAP samples are removed from equal sections from the total length of the bar. A portion of each section is converted to chips and a thin (pin) disk for analysis by classical wet chemistry, ICP, AA, and combustion procedures, and the balance remains as a thick disk for OES and X-Ray analysis.



Analytical Reference Materials International

